# BLF6G20-75; BLF6G20LS-75

### **Power LDMOS transistor**

Rev. 02 — 9 February 2009

**Product data sheet** 

#### 1. Product profile

#### 1.1 General description

75 W LDMOS power transistor for base station applications at frequencies from 1800 MHz to 2000 MHz.

Table 1. Typical performance

RF performance at  $T_{case}$  = 25 °C in a common source class-AB production test circuit.

Mode of operation	f	$V_{DS}$	P <sub>L(AV)</sub>	Gp	η <sub>D</sub>	ACPR <sub>400k</sub>	ACPR <sub>600k</sub>	<b>EVM</b> <sub>rms</sub>
	(MHz)	(V)	(W)	(dB)	(%)	(dBc)	(dBc)	(%)
CW	1930 to 1990	28	63	19	52	-	-	-
GSM EDGE	1930 to 1990	28	29.5	19	37.5	-61.5	-73	1.7

#### **CAUTION**



This device is sensitive to ElectroStatic Discharge (ESD). Therefore care should be taken during transport and handling.

#### 1.2 Features

- Typical GSM EDGE performance at frequencies of 1930 MHz and 1990 MHz, a supply voltage of 28 V and an I<sub>Dq</sub> of 550 mA:
  - ◆ Average output power = 29.5 W
  - ◆ Gain = 19 dB
  - ◆ Efficiency = 37.5 %
  - ◆ ACPR<sub>400k</sub> = −61.5 dBc
  - ◆ ACPR<sub>600k</sub> = -73 dBc
  - ◆ EVM<sub>rms</sub> = 1.7 %
- Easy power control
- Integrated ESD protection
- Excellent ruggedness
- High efficiency
- Excellent thermal stability
- Designed for broadband operation (1800 MHz to 2000 MHz)
- Internally matched for ease of use
- Compliant to Directive 2002/95/EC, regarding Restriction of Hazardous Substances (RoHS)



#### 1.3 Applications

■ RF power amplifiers for GSM, GSM EDGE, W-CDMA and CDMA base stations and multi carrier applications in the 1800 MHz to 2000 MHz frequency range

### 2. Pinning information

Table 2. Pinning

Pin	Description		Simplified outline	Graphic symbol
BLF6G2	0-75 (SOT502A)			
1	drain			
2	gate		1 3	1 اـــان
3	source	<u>[1]</u>		2
				;   3 sym112
BLF6G2	0LS-75 (SOT502B)			
1	drain			
2	gate		1 3	1 
3	source	<u>[1]</u>		2
				3
				sym112

<sup>[1]</sup> Connected to flange.

### 3. Ordering information

Table 3. Ordering information

Type number	Package						
	Name	Description	Version				
BLF6G20-75	-	flanged LDMOST ceramic package; 2 mounting holes; 2 leads	SOT502A				
BLF6G20LS-75	-	earless flanged LDMOST ceramic package; 2 leads	SOT502B				

## 4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DS}$	drain-source voltage		-	65	V
$V_{GS}$	gate-source voltage		-0.5	+13	V
$I_D$	drain current		-	18	Α
$T_{stg}$	storage temperature		-65	+150	°C
T <sub>j</sub>	junction temperature		-	225	°C

#### 5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Туре	Тур	Unit
$R_{\text{th(j-case)}}$	thermal resistance	T <sub>case</sub> = 80 °C;	BLF6G20-75	0.9	K/W
	from junction to case	$P_L = 29.5 \text{ W (CW)}$	BLF6G20LS-75	0.75	K/W

#### 6. Characteristics

Table 6. Characteristics

 $T_i = 25 \,^{\circ}C$  unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{(BR)DSS}$	drain-source breakdown voltage	$V_{GS} = 0 \text{ V}; I_D = 0.5 \text{ mA}$	65	-	-	V
V <sub>GS(th)</sub>	gate-source threshold voltage	$V_{DS} = 10 \text{ V}; I_{D} = 100 \text{ mA}$	1.4	2	2.4	V
$V_{GSq}$	gate-source quiescent voltage	$V_{DS} = 28 \text{ V}; I_{D} = 600 \text{ mA}$	1.6	2.1	2.6	V
I <sub>DSS</sub>	drain leakage current	$V_{GS} = 0 \text{ V}; V_{DS} = 28 \text{ V}$	-	-	3	μΑ
I <sub>DSX</sub>	drain cut-off current	$V_{GS} = V_{GS(th)} + 3.75 \text{ V};$ $V_{DS} = 10 \text{ V}$	14.9	18.5	-	Α
I <sub>GSS</sub>	gate leakage current	$V_{GS} = 11 \text{ V}; V_{DS} = 0 \text{ V}$	-	-	300	nΑ
9 <sub>fs</sub>	forward transconductance	$V_{DS} = 10 \text{ V}; I_{D} = 5 \text{ A}$	-	7	-	S
R <sub>DS(on)</sub>	drain-source on-state resistance	$V_{GS} = V_{GS(th)} + 3.75 \text{ V};$ $I_D = 3.5 \text{ A}$	-	0.15	0.235	Ω
C <sub>rs</sub>	feedback capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 28 \text{ V};$ f = 1 MHz	-	1.6	-	pF

### 7. Application information

Table 7. Application information

Mode of operation: GSM EDGE; f = 1930 MHz and 1990 MHz; RF performance at  $V_{DS}$  = 28 V;  $I_{Dq}$  = 550 mA;  $T_{case}$  = 25 °C; unless otherwise specified; in a class-AB production test circuit.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$P_{L(AV)}$	average output power		-	29.5	-	W
Gp	power gain	$P_{L(AV)} = 29.5 \text{ W}$	17.5	19	-	dB
RLin	input return loss	$P_{L(AV)} = 29.5 \text{ W}$	-	-10	-5.5	dB
$\eta_{D}$	drain efficiency	$P_{L(AV)} = 29.5 \text{ W}$	33.5	37.5	-	%
ACPR <sub>400k</sub>	adjacent channel power ratio (400 kHz)	$P_{L(AV)} = 29.5 \text{ W}$	-	-61.5	-59.5	dBc
ACPR <sub>600k</sub>	adjacent channel power ratio (600 kHz)	$P_{L(AV)} = 29.5 \text{ W}$	-	-73	-69.5	dBc
EVM <sub>rms</sub>	RMS EDGE signal distortion error	$P_{L(AV)} = 29.5 \text{ W}$	-	1.7	3	%
$EVM_M$	peak EDGE signal distortion error	$P_{L(AV)} = 29.5 \text{ W}$	-	4.8	10	%

#### 7.1 Ruggedness in class-AB operation

The BLF6G20-75 and BLF6G20LS-75 are capable of withstanding a load mismatch corresponding to VSWR = 10 : 1 through all phases under the following conditions:  $V_{DS} = 28 \text{ V}$ ;  $I_{Dq} = 550 \text{ mA}$ ;  $P_L = 75 \text{ W}$  (CW); f = 1990 MHz.

#### 7.2 One-tone CW

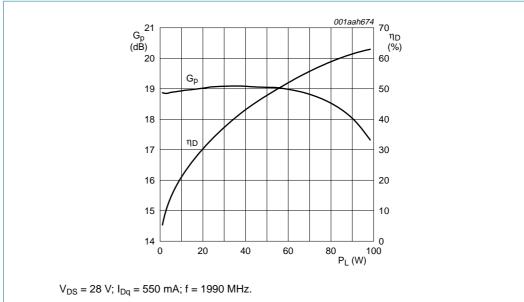
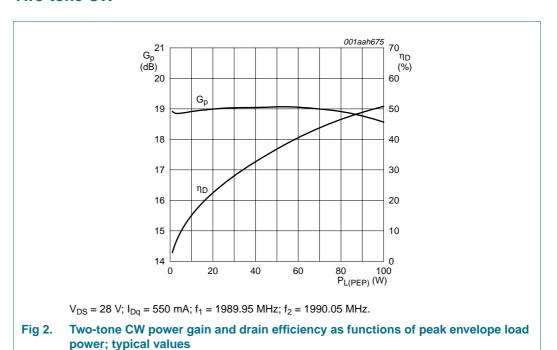
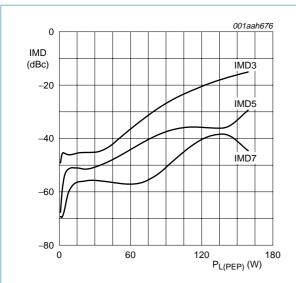


Fig 1. One-tone CW power gain and drain efficiency as functions of load power; typical values

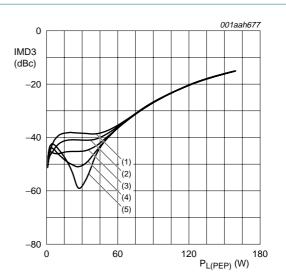
#### 7.3 Two-tone CW





 $V_{DS} = 28 \text{ V}; I_{Dq} = 550 \text{ mA}; f_1 = 1989.95 \text{ MHz}; f_2 = 1900.05 \text{ MHz}.$ 

Fig 3. Two-tone CW intermodulation distortion as function of peak envelope load power; typical values



 $V_{DS} = 28 \text{ V}$ ;  $f_1 = 1989.95 \text{ MHz}$ ;  $f_2 = 1900.05 \text{ MHz}$ .

- (1) 450 MHz
- (2) 500 MHz
- (3) 550 MHz
- (4) 600 MHz
- (5) 650 MHz

Fig 4. Third order intermodulation distortion as a function of peak envelope load power; typical values

#### 7.4 GSM-EDGE

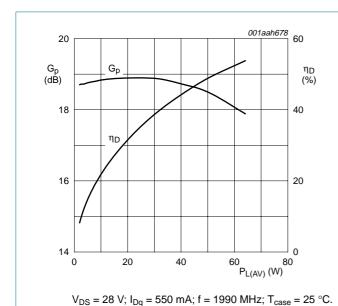
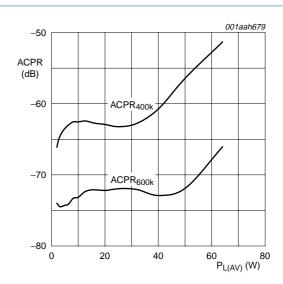
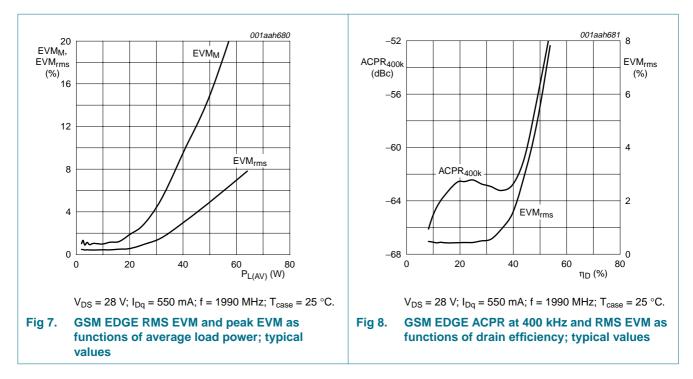


Fig 5. GSM-EDGE power gain and drain efficiency as functions of average load power; typical values

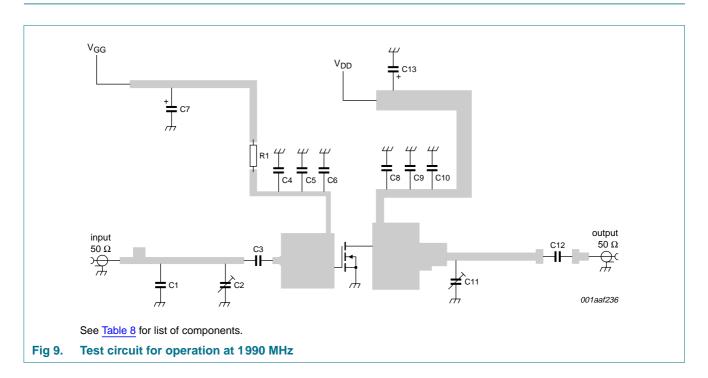


 $V_{DS}$  = 28 V;  $I_{Dq}$  = 550 mA; f = 1990 MHz;  $T_{case}$  = 25 °C.

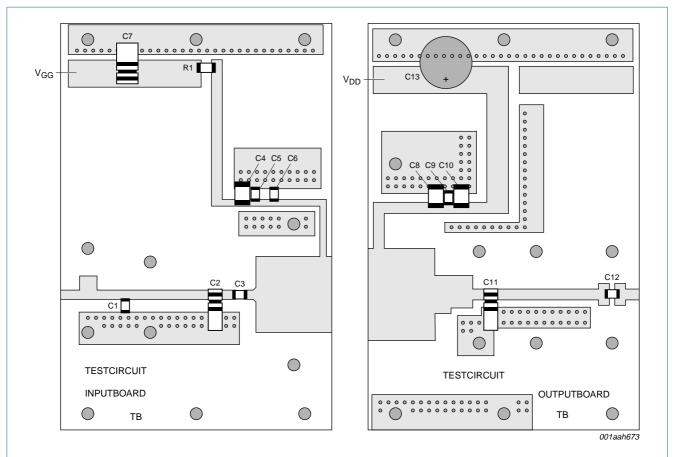
Fig 6. GSM-EDGE ACPR at 400 kHz and at 600 kHz as functions of average load power; typical values



#### 8. Test information



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The striplines are on a double copper-clad Taconic RF35 Printed-Circuit Board (PCB) with  $\epsilon_r$  = 3.5 and thickness = 0.76 mm. See <u>Table 8</u> for list of components.

Fig 10. Component layout for 1990 MHz test circuit

Table 8. List of components (see Figure 9 and Figure 10)

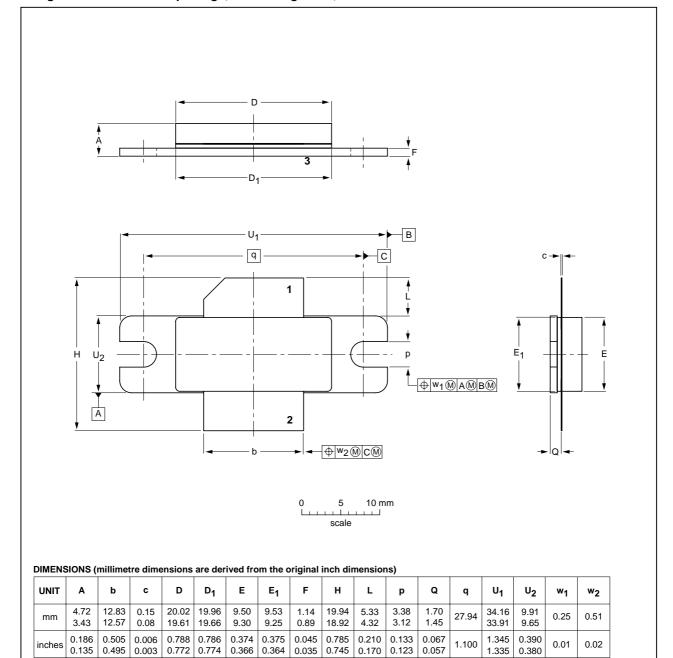
Component	Description	Value	Remarks
C1	multilayer ceramic chip capacitor	1 pF	[1]
C2, C11	gigahertz trimmer	0.6 pF to 4.5 pF	Temex AT SM270 or equivalent
C3, C6, C9	multilayer ceramic chip capacitor	12 pF	[1]
C4, C8, C10	multilayer ceramic chip capacitor	10 μF; 50 V	TDK C5750X7R1H106M or equivalent
C5	multilayer ceramic chip capacitor	1.5 μF; 50 V	TDK C3225X7R1H155M or equivalent
C7	tantalum capacitor	10 μF; 50 V	Kemet T491 series or equivalent
C12	multilayer ceramic chip capacitor	12 pF	[1]
C13	electrolytic capacitor	220 μF; 50 V	
R1	Philips chip resistor	5.6 Ω; 1206	

<sup>[1]</sup> American Technical Ceramics type 100B or capacitor of same quality.

### 9. Package outline

Flanged LDMOST ceramic package; 2 mounting holes; 2 leads

SOT502A



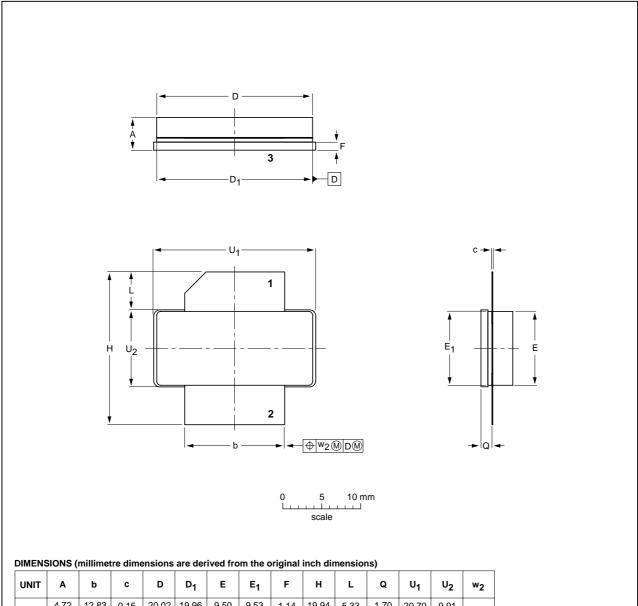
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VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE	
SOT502A						<del>99-12-28</del> 03-01-10	

Fig 11. Package outline SOT502A

BLF6G20-75\_BLF6G20LS-75\_2

#### Earless flanged LDMOST ceramic package; 2 leads

SOT502B



#### 12.83 20.02 19.96 9.53 19.94 4.72 0.15 9.50 1.14 5.33 1.70 20.70 9.91 0.25 mm 3.43 12.57 0.08 19.61 19.66 9.30 9.25 0.89 18.92 4.32 1.45 20.45 9.65 0.186 0.505 0.788 0.786 0.374 0.375 0.045 0.785 0.210 0.815 0.390 0.006 0.067 0.010 inches 0.495 0.003 | 0.772 | 0.774 0.366 0.364 0.035 | 0.745 | 0.170 | 0.057 0.805 0.380

OUTLINE	REFEREN		REFERENCES		EUROPEAN	ISSUE DATE	
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE	
SOT502B						<del>03-01-10-</del> 07-05-09	

Fig 12. Package outline SOT502B

### 10. Abbreviations

Table 9. Abbreviations

Acronym	Description
CDMA	Code Division Multiple Access
CW	Continuous Wave
EDGE	Enhanced Data rates for GSM Evolution
EVM	Error Vector Magnitude
GSM	Global System for Mobile communications
LDMOS	Laterally Diffused Metal-Oxide Semiconductor
LDMOST	Laterally Diffused Metal-Oxide Semiconductor Transistor
RF	Radio Frequency
RMS	Root Mean Square
VSWR	Voltage Standing-Wave Ratio
W-CDMA	Wideband Code Division Multiple Access

### 11. Revision history

#### Table 10. Revision history

Release date	Data sheet status	Change notice	Supersedes			
20090209	Product data sheet	-	BLF6G20-75_1 BLF6G20LS-75_1			
<ul> <li>The document now describes both the eared and earless version of this product: BLF6G20-75 and BLF6G20LS-75 respectively</li> </ul>						
<ul> <li>Table 7 on p</li> </ul>	page 3: changed the minimu	m value for $\eta_D$				
<ul> <li>Table 7 on p</li> </ul>	page 3: changed the maximu	ım value for EVM <sub>rms</sub>				
<ul> <li>Table 7 on p</li> </ul>	page 3: changed the maximu	ım value for EVM <sub>M</sub>				
20080306	Preliminary data sheet	-	-			
20080218	Preliminary data sheet	-	-			
	<ul> <li>The docume BLF6G20-7</li> <li>Table 7 on p</li> <li>Table 7 on p</li> <li>Table 7 on p</li> </ul>	<ul> <li>The document now describes both the end of BLF6G20-75 and BLF6G20LS-75 respension.</li> <li>Table 7 on page 3: changed the maximum of Table 7 on pa</li></ul>	<ul> <li>The document now describes both the eared and earless ve BLF6G20-75 and BLF6G20LS-75 respectively</li> <li>Table 7 on page 3: changed the minimum value for ηD</li> <li>Table 7 on page 3: changed the maximum value for EVM<sub>rms</sub></li> <li>Table 7 on page 3: changed the maximum value for EVM<sub>M</sub></li> <li>Preliminary data sheet</li> </ul>			

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#### 12.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
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